Notice of References Cited Application/Control No. 10/830,058 Applicant(s)/Patent Under Reexamination XI ET AL. Examiner Anthony Weier Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,046,922	09-1977	Burkwall, Jr., Morris P.	426/104
*	В	US-4,695,475	09-1987	Zwiercan et al.	426/582
*	С	US-4,079,155	03-1978	Kakade, Madhu L.	426/634
*	D	US-6,641,855	11-2003	Tomita et al.	426/557
*	E	US-2006/0013937	01-2006	Hagiwara et al.	426/622
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	J	US-		·	
	, K	US-			
	الم	US-			
	М	ÜS-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 61-25454	02-1986	Japan		
	0	JP 58-146249	08-1983	Japan		
	Р	JP 2003-52324	02-2003	Japan		
	a					•
	R				•	
	s					
	Т					·

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	·V	•
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.